To: SKST

Specification number: EQM08-1KC-E169K02

Date of issue: 6 September, 2016

Multilayer ceramic Chip capacitor specification

Product Part No

CM03X5R105M10AH

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RoHS Compliant

Kyocera Corporation Capacitor Division



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1. Application

This specification is applied to the multilayer ceramic Chip capacitor supplied from KYOCERA.

2. Nomenclature

(Ex)	<u>CM</u>	<u>03</u>	<u>X5R</u>	<u>105</u>	<u>M</u>	<u>10</u>	<u>A</u>	<u>H</u>
	(1)	(2)	(3)	(4)	(5)	(6)	(7)	(8)

(0201size / X5R / 1,000,000pF ± 20% / 10V)

- (1)Series CM Series
- (2)Size
- (3)Temperature Characteristics
- (4)Nominal capacitance
- (5)Tolerance
- (6)Voltage
- (7)Termination A:Nickel barrier / Tin
- (8)Packaging type



3. Structure

(1) Size

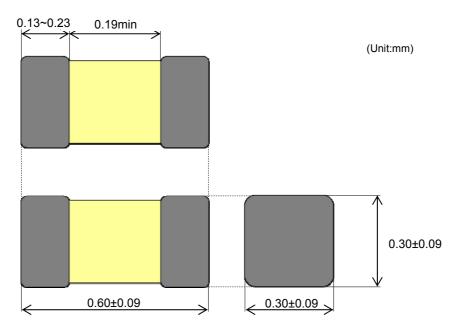


Fig.1 Dimension

(2) Appearance

No problem is observed under a microscope .

(3) Internal structure

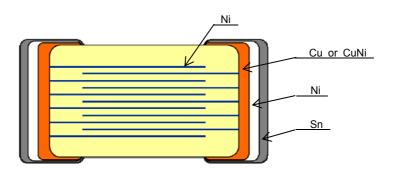


Fig.2 Internal structure



4. Electrical properties

No	Item	Test Cond	litions		Specifications
1	Temperature characteristic of capacitance	Voltage	or 24±2 hours.	No applied voltage	Change in capacitance: Within ±15%
	Nominal capacitance and Tolerance	Keep the sample at 150+0/- the sample at room ambient t Frequency Voltage	*	Within 1,000,0	00 pF ± 20%
3		Keep the sample at 150+0/- the sample at room ambient t Frequency Voltage	*	Within 20.0%	
4	Rated voltage	-		10V	
5	Insulation- resistance	Measure after 10V is applied for room ambient. Charge and discharge current is		5MΩ or over	
6	Dielectric Resistance	25 V(2.5 times of rated voltage 1 to 5seconds. Charge and discharge current is		Dielectric brea	kdown should not occur.



5. Reliability

No	Item	Test Conditions Specifications			
		Keep the sample at 150+0/- 10 °C for 1 hour, leave the sample at room ambient for 24±2 hours. Measure the initial capacitance and dissipation factor		No problem observed	
		< Temperature cycle regulation > Stage Temperature Time 1 Room temperature 3min Lowest operation temperature 3 Room temperature 3min	Capacitance Change	Within ±25% of the initial capacitance.	
1	Temperature cycle	Highest operation temperature 30min temperature 30min 4 After 5 cycle, measure after 24±2 hours.	Dissipation Factor(tanδ)	Within 20.0%.	
		The charge and discharge current of the capacitor must no exceed 50mA for IR and withstanding voltage measurement. (Unit:mm)	IR	5M Ω or over	
		0.92 0.26 Fig. 3. Substrate for temperature cycle test	Dielectric Resistance	Dielectric breakdown should not occur.	
		Apply the below mentioned test condition for 1 hour, then leave the sample at room ambient for 24±2 hours and measure the initial capacitance and dissipation factor.	Appearance	No problem observed	
2	Load humidity test	After applying 10V for 500+12/-0 hours in pre-condition at 40±2°C, humidity 90% to 95%RH, allow parts to stabilize fo	Capacitance or Change	Within ±25% of the initial capacitance	
۷		24±2 hours, at room temperature before measurement. Charge and discharge current of the capacitor must reviewed 50mA for IR measurement.	Dissipation Factor(tanδ)	Within 40.0%	
		Substrate for test is referred to Fig.3.	IR	0.5M Ω or over	



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١	No	Item	Test Conditions	Specifications		
			Apply the below mentioned test condition for 1 hour, then leave the sample at room ambient for 24±2 hours and measure the initial capacitance and dissipation factor.	Appearance	No problem observed	
		High-	to stabilize for 24±2 hours, at room temperature before measurement.	Capacitance Change	Within ±25%of the initial capacitance.	
	3 temperation loading		Charge and discharge current of the capacitor must not exceed 50mA for IR measurement.	Dissipation Factor(tanδ)	Within 40.0%	
			Substrate for test is referred to Fig.3.	IR	1M Ω or over	



6. Soldering Heat Resistance

No	Item	Test Conditions			Specifications		
		Keep the sample at sample at room am Measure the initial of	pient for 24±2 hours	•		Appearance	No problem observed
		<pre-he< td=""><td colspan="2"><pre><pre-heating conditions=""> Order Temperature Time 1 80~100°C 2min</pre-heating></pre></td><td>]</td><td>Capacitance Change</td><td>Within ±7.5% of the initial capacitance</td></pre-he<>	<pre><pre-heating conditions=""> Order Temperature Time 1 80~100°C 2min</pre-heating></pre>]	Capacitance Change	Within ±7.5% of the initial capacitance
1	Soldering Heat Resistance	Soak the sample in 260±5 °C solder for		2min for	ambient,	Dissipation Factor(tanδ)	Within 20.0%
				,	IR	5MΩ or over	
				Dielectric Resistance	Dielectric breakdown should not occur.		

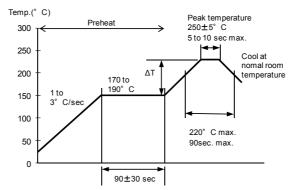
7.Solderability

No	Item	Test Conditions	Specifications			
1	Solderability	Lead-free soldering (Sn-3.0Ag-0.5Cu) Soak the sample in 245±5 °C lead-free solder for 3±0.5 seconds. Eutectic solder Soak the sample in 235±5 °C eutectic solder for 2±0.5 seconds.	Appearance	Solder coverage: 90% min.		



■For lead-free soldering Recommended temperature profile

•Reflow porfile

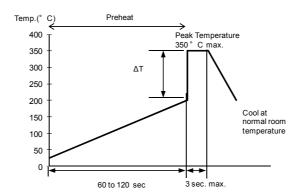


- (1) Minimize soldering time
- (2) Ensure that the temperature difference does not exceed 150 °C.
- (3) MLCC can withstand the above reflow conditions up to 3 times.
- (4) Cool naturally after soldering.

•Flow profile

Flow is not applicable for chips with size CM03.

·Soldering iron profile



- (1) Ensure that the chip capacitor is preheated adequately.
- (2) Ensure that the temperature difference between a capacitor and the soldering iron shall not exceed 150 °C.
- (3) Cool naturally after soldering.
- (4) Avoid direct touching to capacitors.
- (5) Tip shape of soldering iron is dia.3.0mm max.
- (6) Wattage 80W max.



8.Mechanical Strength

No	Item	Test Conditions	Specifications			
1	Termination Strength	Apply a sideward force of 2N to a PCB-mounted sample. Substrate material: Glass epoxy. 0.26 0.92 Fig. 4. Substrate for adhesion strength test	Appearance	No problem observed		
2		Keep the sample at 150+0/- 10 °C for 1 hour, leave the sample at room ambient for 24±2 hours. Measure the initial capacitance and dissipation factor. Vibration frequency :10 to 55 (Hz) Amplitude : 1.5mm Sweeping condition : 10 ->55->10Hz/1 minute In X, Y and Z direction : 2 hours each Total 6 hours	Appearance Capacitance Change Dissipation	No problem observed. Within ±20% of the initial capacitance		
		Substrate for test is referred to Figure 3.	Factor(tanδ)	Within 20.0%		



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No	Item	Test Conditions	Specifi	cations
		Keep the sample at 150+0/- 10 °C for 1 hour, leave the sample at room ambient for 24±2 hours. Measure the initial capacitance. Substrate material: Glass epoxy Test time : 10 seconds Bend depth 1.0 Pressure 90 (Unit:mm) Fig. 5 Testing status	Appearance	No problem observed.
3	Bending Strength	0.26 1±0.1 0.32 0.92 100 (Unit:mm) Fig. 6 Substrate for bending test		Within ±10% of the initial capacitance.



9.Packaging material

(1) Plastic reel dimensions

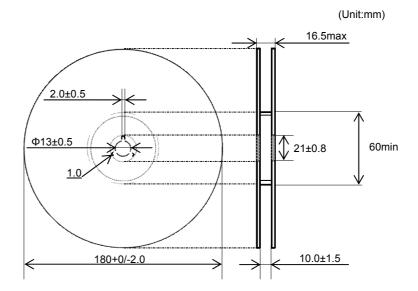


Fig.7 Reel dimensions

(2) Carrier tape dimensions

Pitch=2.0±0.05mm (Packaging code:H) Paper carrier tape

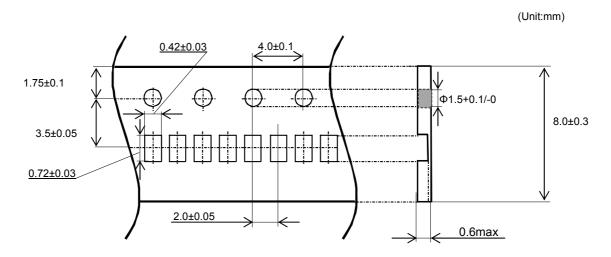


Fig 8.Carrier tape dimensions

(3) Maximum packaging quantity

Maximum packaging quantity : 15000 pieces / Φ 180mm reel



10.Packaging style

- 1. Taping
- (1) Taping packaging

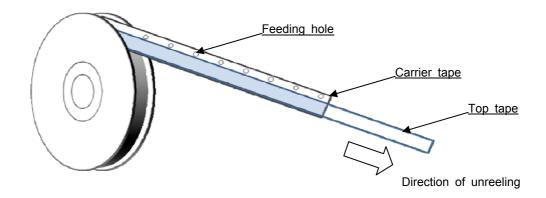


Fig. 9 Taping packaging schema

There are no capacitors in the leader and the trailer portion in taping packaging (refer to Fig. 10). End of the tape is not fixed to the reel to be released from the hub.

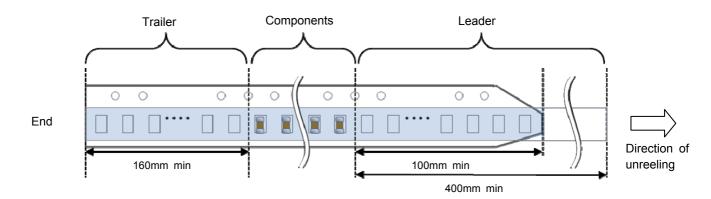


Fig.10 Detail of leader and trailer



(2) Peeling strength of the top tape

The peeling strength when peeling off the top tape from the carrier tape by the method of the following figrue shall be 0.1 to 0.7 N. (Refer to Fig 11)

Peeling angle: 165 to 180 degrees to the carrier tape.

Peeling speed: 300mm/min

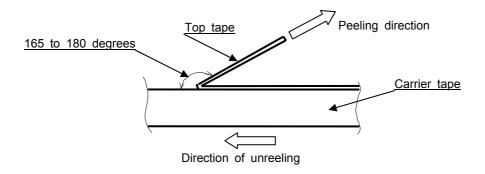


Fig.11 Peeling of the top tape (cross sectional view)

(3) Others

When bent a carrier tape at 25mm in radius, there is neither lack of a capacitor nor breakage of a tape (refer to Fig. 12).

When a top tape is peeled off, glue of the top tape adheres to the top tape side. Capacitors should not be adhered to the top tape.

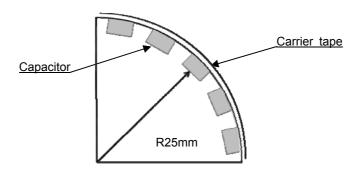


Fig.12 Carrier tape bending (cross sectional view)



11.Label and location

(1) Label location for reels

The label shall be placed on one side of a reel (refer to Fig. 13).

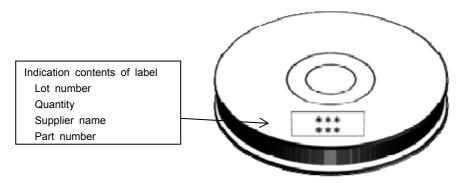


Fig. 13 Label location for reels

(2) Label location for packaging boxes

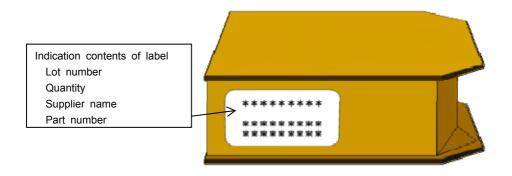


Fig. 14 Label location for packaging boxes

12.Production Site

Kagoshima Kokubu plant (1-1, Kokubu-yamashita-cho, Kirishima-shi, Kagoshima)

Shanghai Kyocera electronics (No. 2077 New Jin Qiao Road Jin Qiao Pudong Shanghai 201206)



13.Precautions

Handling

- 1) Cracks may occur unless otherwise avoiding excessive stress to the capacitors by the load of an adsorption nozzle, and bending of a substrate at the time of mounting.
- 2) Please arrange the capacitor position where they don't have too much stress of board bending after mounting.
- 3) Please design that the form and size of the land pattern has suitable solder amount.

 Otherwise cracks may occur. The recommended fillet height shall be 1/2 to 1/3 of the thickness of capacitors.

Circuit Design

- 1) When AC voltage is superimposed on DC voltage, the zero-to-peak voltage shall not exceed the rated voltage. When the capacitor is to be employed in a circuit in which there is continuous application of a high frequency Voltage or a steep pulse voltage, even though it is within the rated voltage, please inquire to the manufacturer.
- 2) Please use the capacitor below the maximum temperature. When using the capacitor in a self-heating AC circuit, please make sure the surface of the capacitor remains under the maximum temperature for usage. Also, please make certain temperature rises remain below 20 °C.

Resin coating

Please use the resin of low curing shrinkage type. (Otherwise cracks may occur).

Storage

- 1) When the components is stored in minimal packaging (a heat-sealed or chuck-type plastic bag), the bag should be kept closed. Once the bag has been opened, reseal it or store it in a desiccator.
- 2) Keep storage place temperature +5 to +40 °C, humidity 20 to 70% RH.
- 3) The storage atmosphere must be free of gas containing sulfur and chlorine. Also, avoid exposing the product to saline moisture. If the product is exposed to such atmospheres, the terminals will oxidize and solderability will be effected.
- 4) Precautions 1) to 3) apply to chip capacitors packaged in carrier tapes and bulk cases.
- 5) The solderability is assured for 6 months from our shipping date if the above storage precautions are followed.

Application Restriction

Please consult with us before using a capacitor in the equipment which requires a high degree reliability (medical equipment, aerospace applications, nuclear equipment.) Malfunctions in medical, space, nuclear power or other vital equipment may result in death or great social losses. Capacitors designed specially with high reliability are used for the equipment above.

■ Export regulation

When the applying products relate the strategic materials which are provided in Foreign Exchange and Foreign Trade Act and Foreign Trade Management Law, the export license based on these laws are required.

Disposal

Please dispose the capacitors according to the relating laws about the waste treatment and cleaning. Safety application guideline and detailed information of electrical properties are also provided in Kyocera home page:

URL: http://www.kyocera.co.jp/electronic

Notice:

This specification shall guarantee only monolithic capacitors. Please make sure the performance of capacitors after mounted on the assembled product.

Any failures occurred being used out of this specification shall not be quaranteed.

This specification shall be applied to the products purchased through the regular sales routes, such as the sale offices, the subsidiaries and the distributors, etc.).



14.Revision History

14.Revision History							
Date	Contents	APPD	CHKD	CHKD	PREPD		



单击下面可查看定价,库存,交付和生命周期等信息

>>Kyocera(京瓷)